


<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/075,264	CHIU ET AL.	
	Examiner	Art Unit	
	Brian Jelinek	2615	

ISSUE CLASSIFICATION										
ORIGINAL				CROSS REFERENCE(S)						
CLASS	SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)					
348	169			348	349					
INTERNATIONAL CLASSIFICATION				382	103	170				
H	0	4	N	5/225						
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<i>Brian Jelinek</i> 7/11/2005 (Assistant Examiner) (Date)		<i>David L. Ometz</i> 7/19/05 <b>DAVID L. OMETZ</b> PRIMARY EXAMINER (Primary Examiner) (Date)		Total Claims Allowed: 10	
<i>[Signature]</i> 7-20-05 (Legal Instruments Examiner) (Date)				O.G. Print Claim(s) 1	O.G. Print Fig. 4

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant				<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
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7	8		38		68		128		188
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